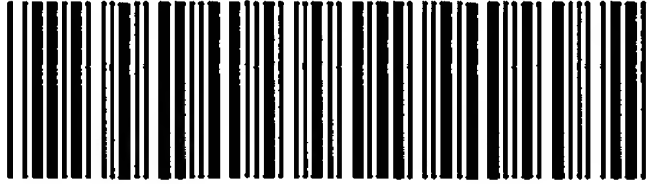


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/614,165	LIN, HSI YANG	
	<b>Examiner</b>	<b>Art Unit</b>	
	Chuck Huynh	2683	

SEARCHED			
Class	Subclass	Date	Examiner
455	569.2	5/24/2005	CH
455	553.1	5/24/2005	CH
455	41.2	5/24/2005	CH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Class/ Subclass	5/24/2005	CH
Text Search	5/23/2005	CH